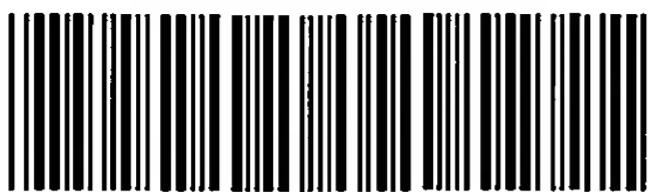


Search Notes



Application/Control No.

10/632,641

Examiner

Edward Wojciechowicz

**Applicant(s)/Patent under
Reexamination**

CHANG ET AL.

Art Unit

2815

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
287	347, 348 365, 401, 406 411	4-1-05	Ed